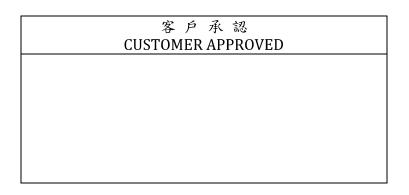


客户名稱 CUSTOMER	:	
客户料號 CUSTOMER'S P/N	:	
料號 PART NUMBER	:	KBAN3216E245H02
規格 DESCRIPTION	:	Chip Antenna 3216 L Ant 2.45G Type H02
版本 VERSION	:	V1.0
日期 ISSUE DATE	:	2020/08/21



	工程部 R&D CENTER	
承 認 APPROVAL	確認 CHECKED	製 作 DRAWN
Ziv	Alex	Jerry



萬誠科技股份有限公司

112 台北市北投區立功街 151 號 1 樓

OneWave Electronic Co., Ltd.

1F, No. 151, Li Gong Street, Beitou District, Taipei City 112, Taiwan

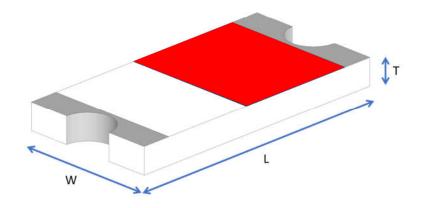
TEL: +886 2 2898-2220 FAX: +886 2 2898-5055

電話: (02) 2898-2220 傳真: (02) 2898-5055



3216 Chip antenna

For Bluetooth / WLAN Applications



P/N: KBAN3216E245H02

	Dimension (mm)		
L	3.23 ± 0.20		
W	1.66 ± 0.20		
Т	0.45 ± 0.20		

Part Number Information

KBAN	<u>3216</u>	<u>E</u>	<u>245</u>	H	<u>02</u>
Α	В	С	D	Е	F

Α	Product Series	Antenna
В	Dimension L x W	3.2 x 1.6mm (±0.2mm)
С	Material	High K material
D	Working Frequency	2.4 ~ 2.5GHz
Е	Feeding mode	PIFA & Single Feeding
F	Antenna type	Type = 02

1. Electrical Specification

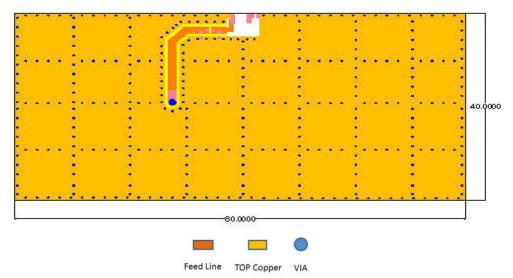
Specification				
Part Number	KBAN3216E245H02			
Central Frequency	2450	MHz		
Bandwidth	120 (Min.)	MHz		
Return Loss	-6.5 (Max)	dB		
Peak Gain	1.71	dBi		
Impedance	50	Ohm		
Operating Temperature	-40~+110	°C		
Maximum Power	4	W		
Resistance to Soldering Heats	10 (@ 260°C)	sec.		
Polarization	Linear			
Azimuth Beamwidth	Omni-directional			
Termination	Termination Ni / Au (Leadless)			

Remark : Bandwidth & Peak Gain was measured under evaluation board of next page

KUBDANT

2. Recommended PCB Pattern

若未參照我司規格書上Layout建議做設計· Evaluation Board Dimension 進而造成後續生產上的天線特性與品質差異問題 · 我司將不負責處理 .

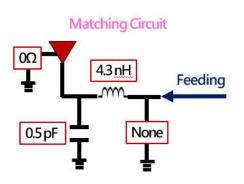


2nd Evaluation Board Dimension

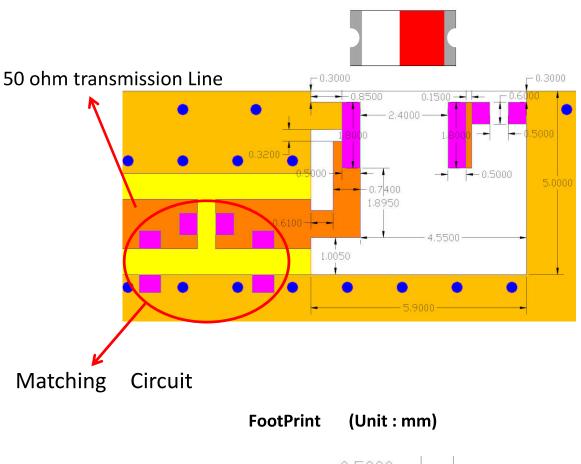
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		******	1.1.1.1.1.1				
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		- *			•	* 3	• • • •
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			•		•	•	•
• • • •			12 C 1 C 1 C 1 C 1 C 1 C 1 C 1 C 1 C 1 C	1997 - T. T. T. T.	200 C C C C		
			12	1.0			10 C
	1999 - 1999 - 1999 - 1999 - 1999 - 1999 - 1999 - 1999 - 1999 - 1999 - 1999 - 1999 - 1999 - 1999 - 1999 - 1999 -	· •	•		•	•	
	0.00	*: C		3 9 3			• · · · · · ·

Suggested Matching Circuit

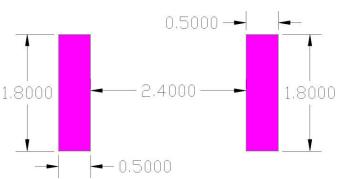
重要<u>資訊</u>: 匹配元件建議使用精準度高的電感±0.1~0.3nH、電容±0.1pF



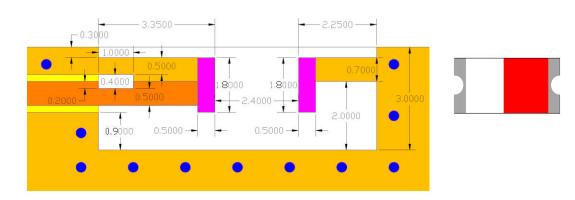




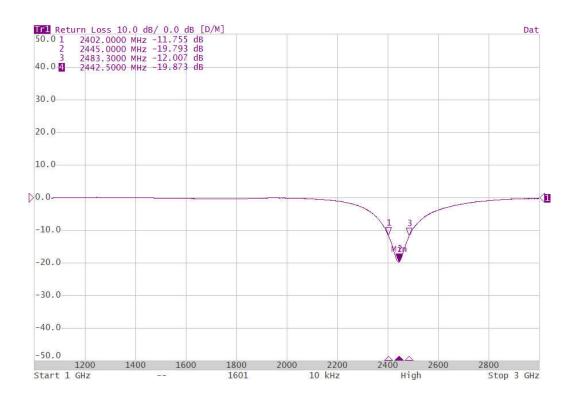
Layout Dimensions in Clearance area(Size=5.9*5.0mm)



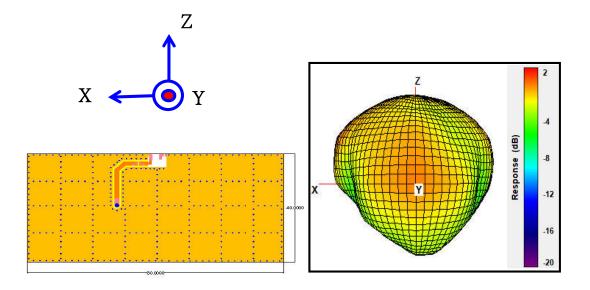
• 2nd Layout Dimensions in Clearance area(Size=8.0*3.0mm)



3. Measurement Results Return Loss

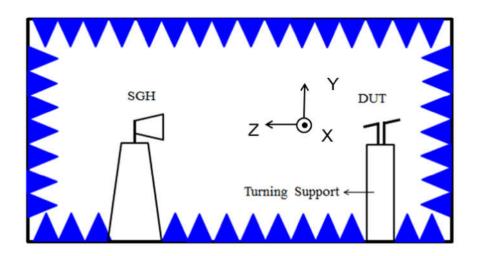


Radiation Pattern



	Efficiency	Peak Gain	Directivity
2400MHz	77.26 %	1.63 dBi	2.75 dBi
2450MHz	79.88 %	1.71 dBi	2.68 dBi
2500MHz	77.98 %	1.67 dBi	2.75 dBi

Chamber Coordinate System



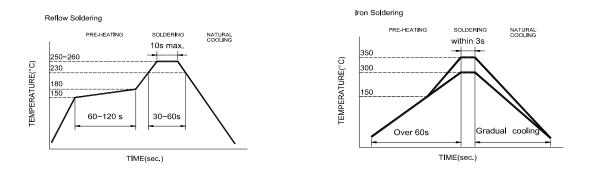


4.Reliability and Test Condictions

ITEM	REQUIREMENTS	TEST CONDITION		
Solderability	1. Wetting shall exceed 90% coverage	Pre-heating temperature:150 $^\circ C$ /60sec. Solder temperature:230 \pm 5 $^\circ C$		
	2. No visible mechanical damage			
	TEMP (°C)	Duration:4±1sec.		
		Solder:Sn-Ag3.0-Cu0.5		
	230℃ <u>4±1 sec.</u>	Flux for lead free: rosin		
	150°C			
	60sec			
Solder heat	1. No visible mechanical damage	Pre-heating temperature:150°C/60sec.		
Resistance	2. Central Freq. change :within ± 6%	Solder temperature:260±5°C		
	TEMP (°C)	Duration:10±0.5sec.		
	10+0 5 222	Solder:Sn-Ag3.0-Cu0.5		
	260°C 10±0.5 sec.	Flux for lead free: rosin		
	150°C			
	60sec			
Component	1. No visible mechanical damage	The device should be reflow		
Adhesion (Push test)		soldered($230\pm5^{\circ}$ °C for 10sec.) to a tinned		
()		copper substrate A dynometer force gauge should be applied the side of the		
		component. The device must with-ST-F		
		0.5 Kg without failure of the termination		
		attached to component.		
Component	1. No visible mechanical damage	Insert 10cm wire into the remaining open		
Adhesion		eye bend ,the ends of even wire lengths		
(Pull test)		upward and wind together.		
		Terminal shall not be remarkably		
Thermal shock	1. No visible mechanical damage	damaged. +110℃=>30±3min		
	-	-40°C=>30±3min		
	2. Central Freq. change :within ±6%	Test cycle:10 cycles		
	Phase Temperature(°C) Time(min)	The chip shall be stabilized at normal		
	1 +110±5℃ 30±3	condition for 2~3 hours before		
	2 Room Within	measuring.		
	Temperature 3sec			
	3 -40±2°C 30±3			
	4 Room Within			
	Temperature 3sec			
Resistance to	1. No visible mechanical damage	Temperature: +110±5℃		
High	2. Central Freq. change :within ±6%	Duration: 1000±12hrs		
Temperature	3. No disconnection or short circuit.	The chip shall be stabilized at normal		
		condition for 2~3 hours before		
		measuring.		
Resistance to	1. No visible mechanical damage	Temperature:-40±5℃		
Low	2. Central Freq. change :within ±6%	Duration: 1000±12hrs		
Temperature	3. No disconnection or short circuit.	The chip shall be stabilized at normal		
		condition for 2~3 hours before		
Lunaidit	A Ne visible mechanistic tot	measuring. Temperature: 40±2℃		
Humidity	1. No visible mechanical damage	Humidity: 90% to 95% RH		
	2. Central Freq. change :within ±6%	Duration: 1000±12hrs		
	3. No disconnection or short circuit.	The chip shall be stabilized at normal		
		condition for 2~3 hours before		
		measuring.		

5.Soldering and Mounting

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.



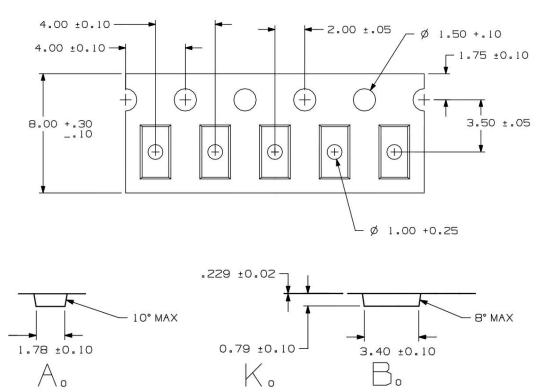
Recommended temperature profiles for re-flow soldering in Figure 1.

Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

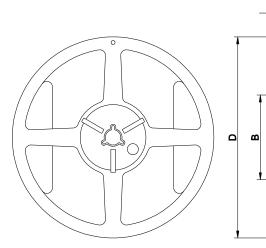
- Preheat circuit and products to $150^\circ C$
- Never contact the ceramic with the iron tip
- Use a 20 watt soldering iron with tip diameter of 1.0mm
- 280°C tip temperature (max)
- 1.0mm tip diameter (max)
- Limit soldering time to 3 sec.

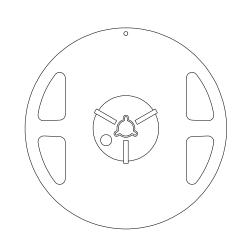
6.Packaging Information

Tape Specification:









7" x 8 mm

C

Tape Width(mm)	A(mm)	B(mm)	C(mm)	D(mm)	Chip/Reel(pcs)
8	9.0±0.5	60±2	13.5±0.5	178±2	3000

7. Storage and Transportation Information

Storage Conditions

To maintain the solderability of terminal electrodes:

- 1. Temperature and humidity conditions: -10~ 40° C and 30~70% RH.
- 2. Recommended products should be used within 6 months from the time of delivery.
- 3. The packaging material should be kept where no chlorine or sulfur exists in the air.

Transportation Conditions

- 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.